





P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(on) max}	I _D T _A = +25°C
-30V	$80m\Omega@V_{GS} = -10V$	-4.0A
-30 V	140mΩ@ V _{GS} =-4.5V	_

Description

This new generation Trench MOSFET has been designed to minimize the on-state resistance ($R_{DS(ON)}$) and yet maintain superior switching performance.

Applications

- Power management functions
- Portable Equipment
- Battery Charging

Features and Benefits

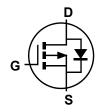
- Low On-Resistance
- Fast Switching Speed
- 4.5V Gate Drive Capability
- Thermally Enhanced SOT23 package
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SOT23
- Case Material: Molded Plastic, "Green" Molding Compound UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin annealed over Copper leadframe Solderable per MIL-STD-202, Method 208 @3
- Terminal Connections: See Diagram
- Weight: 0.008 grams (approximate)







Top View

Pin Configuration

S

Equivalent Circuit

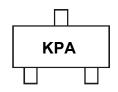
Ordering Information (Note 4)

Part Number	Compliance	Case	Packaging
ZXMP3F30FHTA	Standard	SOT23	3,000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



KPA = Product Type Marking Code YM = Date Code Marking Y = Year (ex: A = 2013) M = Month (ex: 9 = September)

Date Code Key

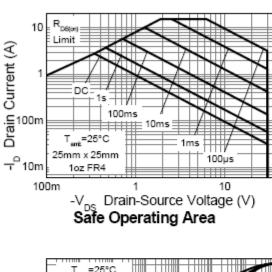
Year	2008		2009	2010		2011	2012		2	2013	2014		2015
Code	V		W	X		Υ	Z			Α	В		С
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Au	ıg	Sep	Oct	No	/ Dec
Code	1	2	3	4	5	6	7	8	3	9	0	Ν	D

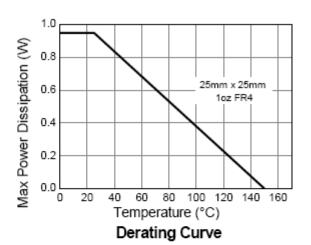


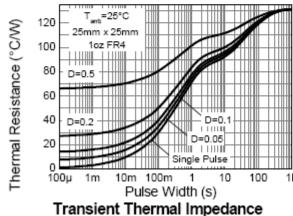
Characteri	stic	Symbol	Value	Units
Drain-Source Voltage		V_{DSS}	-30	V
Gate-Source Voltage	_	V _{GSS}	±20	V
	T _A = +25°C (Note 6)		-3.4	
	$T_A = +70^{\circ}C \text{ (Note 6)}$		-2.7	Δ.
Drain Current, V _{GS} = -10V	$T_A = +25^{\circ}C \text{ (Note 5)}$	I _D	-2.8	А
	T _L = +25°C (Note 8)		-4.0	
Pulsed Drain Current (Note 7)		I _{DM}	-15.3	Α
Continuous Source Current (Body Dio	de) (Note 6)	Is	-2	A
Pulsed Source Current (Body Diode) (I _{SM}	-15.3	Α	

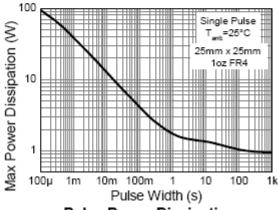
Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units
	T _A = +25°C (Note 5)		0.95 7.6	W mW/°C
Total Power Dissipation (Note 5) Linear Derating Factor	T _A = +25°C (Note 6)	P_{D}	1.4 11.2	W mW/°C
, and the second	T _L = +25°C (Note 8)		1.96 15.7	W mW/°C
Thermal Resistance, Junction to Ambient	(Note 5) (Note 6)	$R_{ hetaJA}$	131 89	°C/W
Operating and Storage Temperature Range	. ,	$T_{J_i} T_{STG}$	-55 to +150	°C









Pulse Power Dissipation



Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	-30	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current	I_{DSS}	1	_	-1	nA	$V_{DS} = -30V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}		_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(th)}$	-1	_	-3	V	$V_{DS} = V_{GS}$, $I_{D} = -250 \mu A$
Static Drain-Source On-Resistance (Note 9)				80	mΩ	$V_{GS} = -10V$, $I_D = -2.5A$
Static Dialii-Source Off-Resistance (Note 9)	R _{DS (ON)}			140	11122	$V_{GS} = -4.5V$, $I_D = -1.9A$
Forward Transconductance (Note 9 & 10)	9 _{fs}		5	_	S	$V_{DS} = -15V, I_{D} = -3A$
Diode Forward Voltage (Note 9)	V_{SD}	_	-0.8	-1.2	V	$V_{GS} = 0V, I_S = -1.7A$
DYNAMIC CHARACTERISTICS (Note 10)						•
Input Capacitance	C _{iss}	1	370	_	pF	\(\delta = \delta \)
Output Capacitance	Coss	1	72	_	pF	V _{DS} = -15V, V _{GS} = 0V, f = 1.0MHz
Reverse Transfer Capacitance	Crss		38	_	pF	1 - 1:01/11/12
GATE CHARACTERISTICS						
Total Gate Charge	Qg		7	_		\\ - 15\\ \\ - 10\\
Gate-Source Charge	Q_{gs}	1	1.2	_	nC	$V_{DS} = -15V$, $V_{GS} = -10V$, $I_{D} = -3A$
Gate-Drain Charge	Q_{gd}		1.3	_		ID3A
SWITCHING CHARACTERISTICS (Note 10 & 11)						
Turn-On Delay Time	t _{d(on)}	_	1.3			
Rise Time	t _r		2.6	_	ns	V_{DS} = -15V, V_{GS} = -10V, I_{D} = -1A, R_{G} = 6.0 Ω
Turn-On Delay Time	t _{d(off)}	_	49	_	115	
Rise Time	t _f	_	22	_		
SOURCE-DRAIN DIODE CHARACTERISTICS (Note	e 11)					
Reverse Recovery Time	t _{rr}	1	14.6	_	ns	-IS= -1.5A,di/dt=100A/µs
Reverse Recovery Charge	Q _{rr}		9.5	_	nC	131.3Α,αι/αι-100Α/μδ

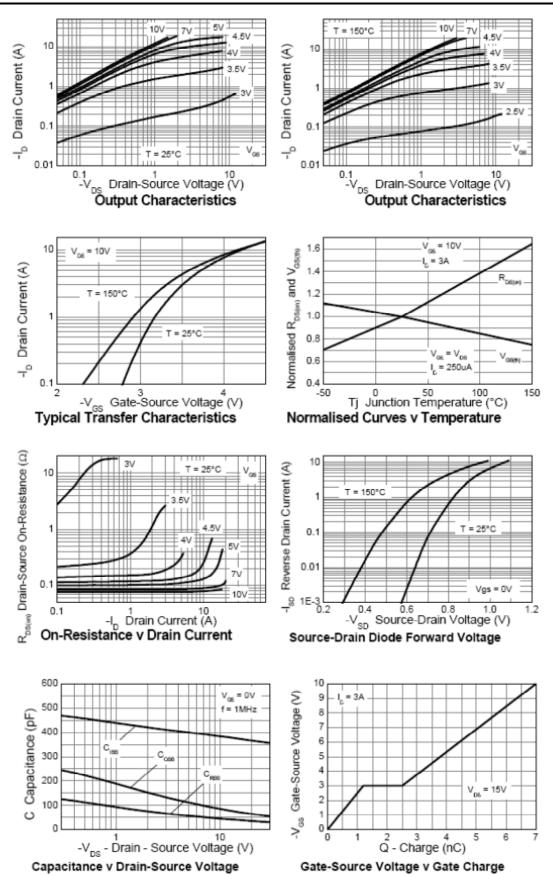
Notes:

- 5. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.
- Mounted on FR4 PCB measured at t ≤ 10 sec.
 Repetitive rating on 25mm x 25mm FR4 PCB, D=0.02, pulse width 300μs pulse width limited by maximum junction temperature.
 Thermal resistance from junction to solder-point (at the end of the drain lead).
 Measured under pulsed conditions. Pulse width ≤ 300μs; duty cycle ≤ 2%.

- 10. Switching characteristics are independent of operating junction temperature.
- 11. For design aid only, not subject to production testing.

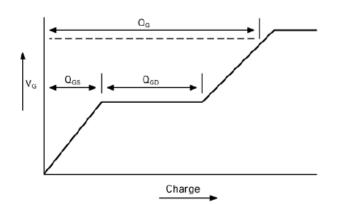


Typical Characteristics

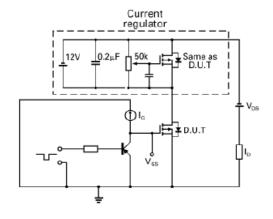




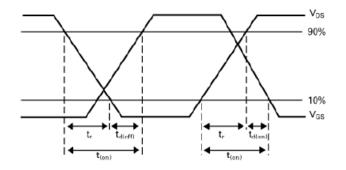
Test Circuits



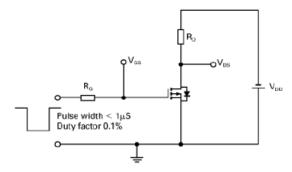
Basic gate charge waveform



Gate charge test circuit



Switching time waveforms

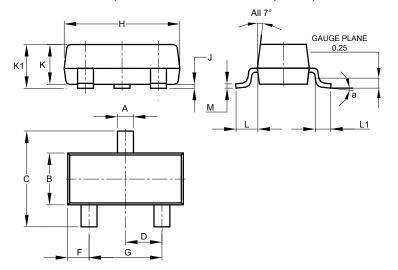


Switching time test circuit



Package Outline Dimensions

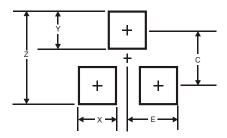
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



SOT23							
Dim	Min	Max	Тур				
Α	0.37	0.51	0.40				
В	1.20	1.40	1.30				
С	2.30	2.50	2.40				
D	0.89	1.03	0.915				
F	0.45	0.60	0.535				
G	1.78	2.05	1.83				
Н	H 2.80		2.90				
J	0.013	0.10	0.05				
K	0.890	1.00	0.975				
K1	0.903	1.10	1.025				
L	0.45	0.61	0.55				
L1	0.25	0.55	0.40				
M	0.085	0.150	0.110				
α	8°						
All Dimensions in mm							

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Z	2.9
X	0.8
Y	0.9
С	2.0
E	1.35



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